

BUK7528-55A N-channel TrenchMOS standard level FET Rev. 02 — 21 April 2011

Product data sheet

Product profile 1.

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

AEC Q101 compliant

Low conduction losses due to low on-state resistance

1.3 Applications

Automotive and general purpose power switching

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	55	V
I _D	drain current	T _{mb} = 25 °C	-	-	42	А
P _{tot}	total power dissipation		-	-	99	W
Static cha	racteristics					
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C	-	23.8	28	mΩ
Avalanche	e ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$ \begin{split} & I_D = 34 \; A; \; V_sup \leq 25 \; V; \\ & R_GS = 50 \; \Omega; \; V_GS = 5 \; V; \\ & T_j(init) = 25 \; ^\circC; \; unclamped \end{split} $	-	-	58	mJ



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2. Pinning information

Table 2.	Pinning	j information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		-
2	D	drain	mb	
3	S	source		
mb	D	mounting base; connected to drain		mbb076 S

3. Ordering information

Table 3.Ordering information

Type number	Package		
	Name	Description	Version
BUK7528-55A	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78A

SOT78A (TO-220AB)

4. Limiting values

Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

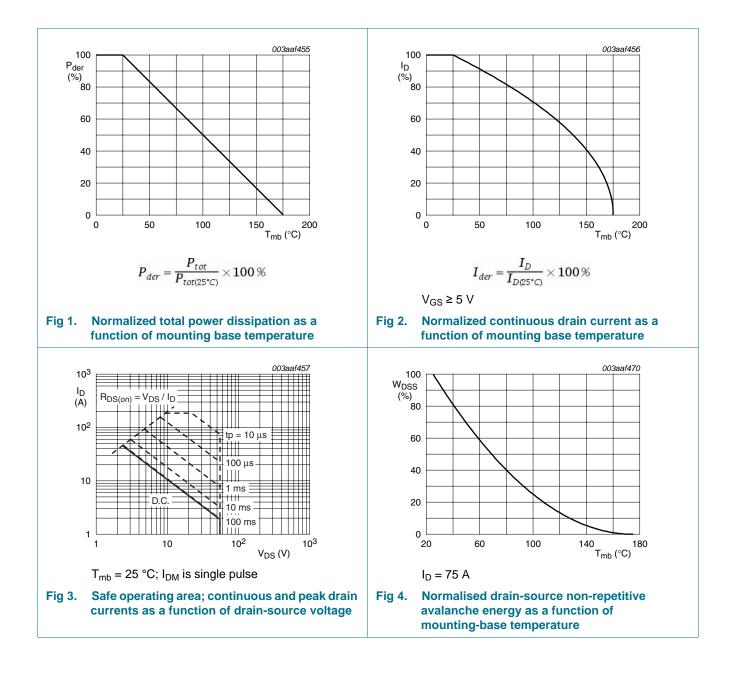
Symbol	Parameter	Conditions	Min	Мах	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	55	V
V _{DGR}	drain-gate voltage	R_{GS} = 20 k Ω	-	55	V
V _{GS}	gate-source voltage		-20	20	V
I _D	drain current	T _{mb} = 25 °C	-	42	А
		T _{mb} = 100 °C	-	30	А
I _{DM}	peak drain current	T _{mb} = 25 °C; pulsed	-	168	А
P _{tot}	total power dissipation	T _{mb} = 25 °C	-	99	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Source-drai	in diode				
I _S	source current	T _{mb} = 25 °C	-	41	А
I _{SM}	peak source current	pulsed; T _{mb} = 25 °C	-	163	А
Avalanche I	ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$I_D = 34 \text{ A}; V_{sup} \le 25 \text{ V}; R_{GS} = 50 \Omega;$ $V_{GS} = 5 \text{ V}; T_{j(init)} = 25 ^{\circ}\text{C}; \text{ unclamped}$	-	58	mJ

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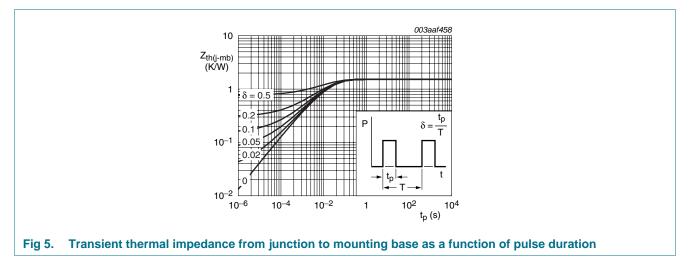
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5. Thermal characteristics

Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base		-	-	1.5	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	-	60	-	K/W

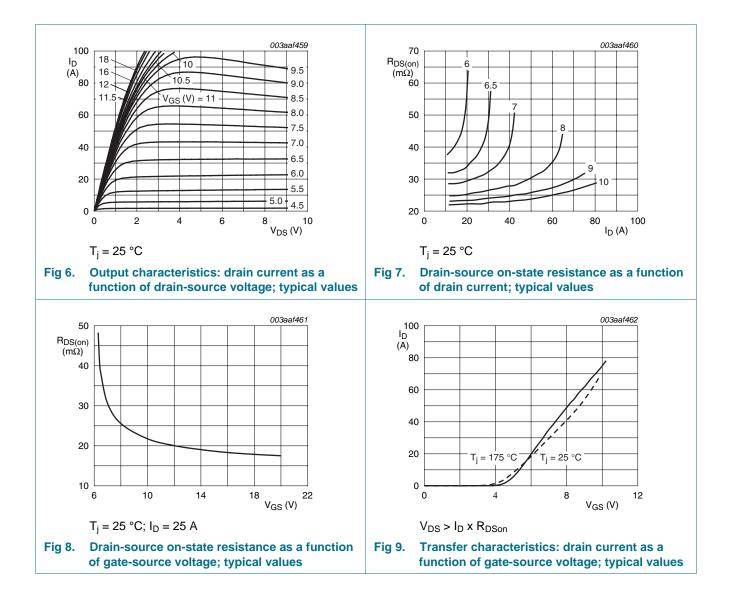


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6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source breakdown	I_D = 0.25 mA; V_{GS} = 0 V; T_j = 25 °C	55	-	-	V
	voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	50	-	-	V
V _{GS(th)}	gate-source threshold	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}$	-	-	4.4	V
	voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	2	3	4	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C}$	1	-	-	V
I _{DSS}	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μΑ
		$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μA
I _{GSS}	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
		V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state	V_{GS} = 10 V; I _D = 25 A; T _j = 175 °C	-	-	56	mΩ
	resistance	V_{GS} = 10 V; I_D = 25 A; T_j = 25 °C	-	23.8	28	mΩ
Dynamic	characteristics					
C _{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$	-	874	1165	pF
C _{oss}	output capacitance	$T_j = 25 \ ^{\circ}C$	-	218	261	pF
C _{rss}	reverse transfer capacitance		-	137	188	pF
t _{d(on)}	turn-on delay time	V_{DS} = 30 V; R_L = 1.2 Ω ; V_{GS} = 5 V;	-	14	21	ns
t _r	rise time	$R_{G(ext)} = 10 \ \Omega; \ T_j = 25 \ ^{\circ}C$	-	68	102	ns
t _{d(off)}	turn-off delay time		-	83	116	ns
t _f	fall time		-	43	60	ns
L _D	internal drain inductance	measured from drain lead 6 mm from package to centre of die ; $T_j = 25 \text{ °C}$	-	4.5	-	nH
		measured from contact screw on tab to centre of die ; $T_j = 25 \text{ °C}$	-	3.5	-	nH
L _S	internal source inductance	measured from source lead to source bond pad ; $T_j = 25 \ ^{\circ}C$	-	7.5	-	nH
Source-d	rain diode					
V _{SD}	source-drain voltage	$I_{S} = 41 \text{ A}; V_{GS} = 0 \text{ V}; T_{j} = 25 \text{ °C}$	-	1.1	-	V
		$I_{S} = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_{j} = 25 \text{ °C}$	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_{S} = 20 \text{ A}; \text{ d}I_{S}/\text{d}t = -100 \text{ A}/\mu\text{s};$	-	45	50	ns
Qr	recovered charge	V_{GS} = -10 V; V_{DS} = 30 V; T_j = 25 °C	-	88	96	nC

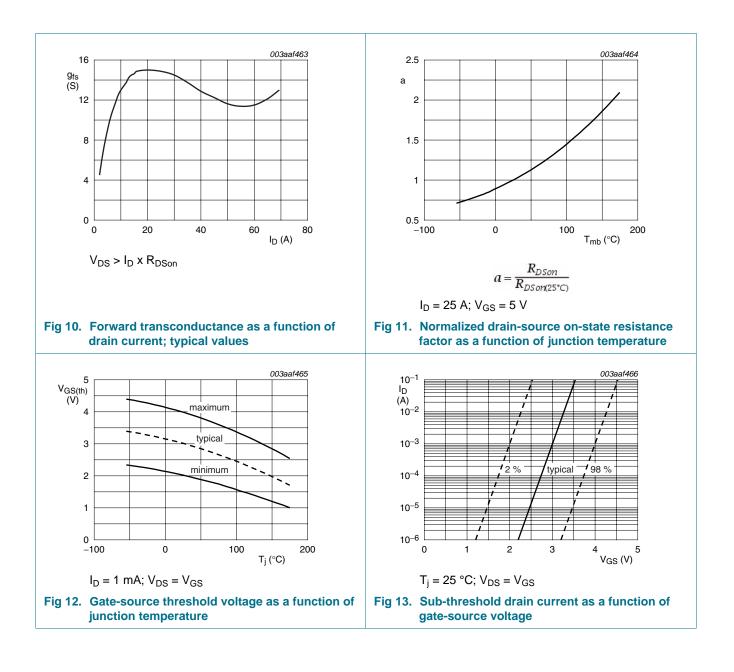
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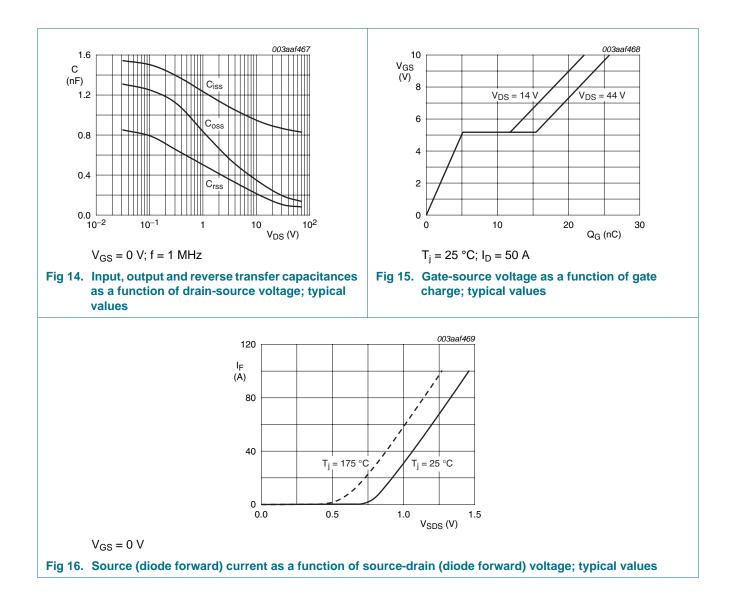
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7. Package outline

scale
IMENSIONS (mm are the original dimensions)
UNIT A A ₁ b b ₁ c D D ₁ E e L $L_1^{(1)}$ $L_2 \atop max.$ p q Q
mm 4.5 1.39 0.9 1.3 0.7 15.8 6.4 10.3 254 15.0 3.30 3.0 3.8 3.0 2.6

Fig 17. Package outline SOT78A (TO-220AB)

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8. Revision history

Table 7. Revision hist	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7528-55A v.2	20110421	Product data sheet	-	BUK7528_7628-55A v.1
Modifications:	guidelines of N Legal texts have 	this data sheet has been IXP Semiconductors. ve been adapted to the n BUK7528-55A separated	ew company name w	here appropriate.
BUK7528_7628-55A v.1	20000601	Product specification	-	-

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9. Legal information

9.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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Date of release: 21 April 2011 Document identifier: BUK7528-55A